

# EAST Search History

ALK

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	39914	polish\$3 same clean\$3	US-PGPUB; USPAT; USOCR; EPO; DERWENT	OR	ON	2006/06/26 13:14
L2	659	(65/61).CCLS.	US-PGPUB; USPAT; USOCR; DERWENT	OR	OFF	2006/06/26 13:14
L3	53	1 and L2	US-PGPUB; USPAT; USOCR; EPO; DERWENT	OR	ON	2006/06/26 13:14
S1	1	("20040137828").PN.	US-PGPUB	OR	OFF	2006/04/13 10:24
S2	13	(mask adj blank and transfer adj mask and substrate).clm.	US-PGPUB; USPAT; USOCR; EPO; DERWENT	OR	ON	2006/04/07 14:29
S3	25603	reticle	US-PGPUB; USPAT; USOCR; EPO; DERWENT	OR	ON	2006/04/11 09:27
S4	609274	((("427") or ("65") or ("428") or ("430") or ("438") or ("451")).CLAS.	US-PGPUB; USPAT; USOCR; DERWENT	OR	OFF	2006/04/11 09:34
S5	5232	S3 and S4	US-PGPUB; USPAT; USOCR; EPO; DERWENT	OR	ON	2006/04/11 09:34
S6	646428	rough\$4	US-PGPUB; USPAT; USOCR; EPO; DERWENT	OR	ON	2006/04/11 09:40
S7	893	S5 and S6	US-PGPUB; USPAT; USOCR; EPO; DERWENT	OR	ON	2006/04/11 09:35

## EAST Search History

S8	542	rough\$4 near nm	US-PGPUB; USPAT; USOCR; EPO; DERWENT	OR	ON	2006/04/11 09:42
S9	1	S5 and S8	US-PGPUB; USPAT; USOCR; EPO; DERWENT	OR	ON	2006/04/11 09:40
S10	82	rough\$4 near nanometer	US-PGPUB; USPAT; USOCR; EPO; DERWENT	OR	ON	2006/04/11 09:41
S11	0	S5 and S10	US-PGPUB; USPAT; USOCR; EPO; DERWENT	OR	ON	2006/04/11 09:41
S12	242	S4 and S8	US-PGPUB; USPAT; USOCR; EPO; DERWENT	OR	ON	2006/04/11 09:50
S13	132061	arf f2 euv	US-PGPUB; USPAT; USOCR; EPO; DERWENT	OR	ON	2006/04/11 09:50
S14	31	S12 and S13	US-PGPUB; USPAT; USOCR; EPO; DERWENT	OR	ON	2006/04/11 09:50
S15	12657	(glass adj substrate).ti.	US-PGPUB; USPAT; USOCR; EPO; DERWENT	OR	ON	2006/04/11 10:11
S16	31	S13 and S15	US-PGPUB; USPAT; USOCR; EPO; DERWENT	OR	ON	2006/04/11 10:12
S17	983	RMS adj5 nm	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2006/04/13 10:44

## EAST Search History

S18	7995	((428/410) or (430/5) or (65/31) or (427/162)).CCLS.	US-PGPUB; USPAT; USOCR; DERWENT	OR	OFF	2006/04/13 10:44
S19	22	S17 and S18	US-PGPUB; USPAT; USOCR; EPO; DERWENT	OR	ON	2006/04/13 11:01
S20	2	jp-2002201042-\$.did.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2006/04/13 11:01
S21	1	("6928837").PN.	USPAT	OR	OFF	2006/06/21 06:44
S22	1	("6593036").PN.	USPAT	OR	OFF	2006/06/21 08:13
S23	1	jp-73006925-\$.did.	US-PGPUB; USPAT; USOCR; EPO; DERWENT	OR	ON	2006/06/21 06:53
S24	1	jp-63114866-\$.did.	US-PGPUB; USPAT; USOCR; EPO; DERWENT	OR	ON	2006/06/21 08:16
S25	840408	defect flaw crack irregularity	US-PGPUB; USPAT; USOCR; EPO; DERWENT	OR	ON	2006/06/21 08:16
S26	635789	etch\$3 elicit\$3	US-PGPUB; USPAT; USOCR; EPO; DERWENT	OR	ON	2006/06/21 08:17
S27	9024	S26 near7 S25	US-PGPUB; USPAT; USOCR; EPO; DERWENT	OR	ON	2006/06/21 08:17
S28	8170	((428/410) or (430/5) or (65/31) or (427/162)).CCLS.	US-PGPUB; USPAT; USOCR; DERWENT	OR	OFF	2006/06/21 08:17

## EAST Search History

S29	382	S27 and S28	US-PGPUB; USPAT; USOCR; EPO; DERWENT	OR	ON	2006/06/21 08:19
S30	6786066	finish\$3 polish\$3 process\$3	US-PGPUB; USPAT; USOCR; EPO; DERWENT	OR	ON	2006/06/21 08:19
S31	292318	S26 same S30	US-PGPUB; USPAT; USOCR; EPO; DERWENT	OR	ON	2006/06/21 08:20
S32	357	S29 and S31	US-PGPUB; USPAT; USOCR; EPO; DERWENT	OR	ON	2006/06/21 09:24
S33	909	(65/31).CCLS.	US-PGPUB; USPAT; USOCR; DERWENT	OR	OFF	2006/06/21 09:33
S34	659	(65/61).CCLS.	US-PGPUB; USPAT; USOCR; DERWENT	OR	OFF	2006/06/26 13:13
S35	83	S33 and S34	US-PGPUB; USPAT; USOCR; EPO; DERWENT	OR	ON	2006/06/21 09:37
S36	3887	(451/41).CCLS.	US-PGPUB; USPAT; USOCR; DERWENT	OR	OFF	2006/06/21 09:38